Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | PARKIN ET AL. | Examiner | Art Unit | Joseph Nguyen | 2815 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0052006	03-2004	Odagawa et al.	360/324.1
*	В	US-6,754,100	06-2004	Hayakawa, Jun	365/173
*	С	US-2004/0136232	07-2004	Hosomi et al.	365/158
*	D	US-6,226,197	05-2001	Nishimura, Naoki	365/171
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Φ					
	σ					
	R					
	S	•				
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	x	

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